

Selectable, Four Channel Video Operational Amplifier

July 1994

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OPERATIONAL
AMPLIFIERS

Features

- This Circuit Is Processed In Accordance to MIL-STD-883 and is Fully Conformant Under the Provisions of Paragraph 1.2.1.
- Digital Selection of Input Channel
- Unity Gain Stable
- Gain Flatness (to 10MHz) 0.12dB (Typ)
- Differential Gain 0.03% (Typ)
- Differential Phase 0.03 Degrees (Typ)
- Fast Channel Selection 100ns (Max)
- Crosstalk Rejection 60dB (Typ)

Applications

- Programmable Gain Amplifier
- Special Effects Processors
- Video Distribution Systems/Multiplexers
- Heads-up/Night Vision Displays
- Radar Video
- Flight Simulators
- IR Imaging

Ordering Information

PART NUMBER	TEMPERATURE RANGE	PACKAGE
HA1-2444/883	-55°C to +125°C	16 Lead CerDIP

Description

The HA-2444/883 is a channel-selectable video op amp consisting of four differential inputs, a single-ended output, and digital control circuitry allowing two digital inputs to activate one of the four differential inputs. The HA-2444/883 also includes a high impedance output state allowing the outputs of multiple HA-2444/883s to be wire-OR'd. Functionally, the HA-2444/883 is equivalent to four wideband video op amps and a wideband multiplexer.

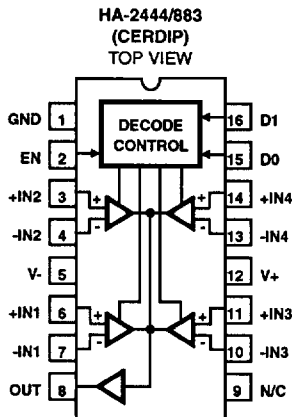
Unlike similar competitor devices, the HA-2444/883 is not restricted to multiplexing. Any op amp configuration can be used with any of the inputs. Signal amplification, addition, integration, and more can be put under digital control with broadcast quality performance.

The key video parameters of the HA-2444/883 have been optimized without compromising DC performance. Gain Flatness, to 10MHz, is only 0.12dB. Differential gain and phase are typically 0.03% and 0.03 degrees, respectively.

Laser trimming allows offset voltages in the 4.0mV range and a unique common current source design assures minimal channel-to-channel mismatch, while maintaining 60dB of crosstalk rejection at 5MHz. Open loop gain of 76dB and low input offset and bias currents enhance the performance of this versatile device.

Uses for the HA-2444/883 include video test equipment, guidance systems, radar displays, and other precise imaging systems where stringent gain and phase requirements have previously required costly hybrids and discrete circuitry. It will also be used for systems requiring high speed signal conditioning, such as data acquisition systems, specialized instrumentation, and communications systems.

Pinout



Logic Operation

TRUTH TABLE

EN	D1	D0	SELECTED CHANNEL
H	L	L	1
H	L	H	2
H	H	L	3
H	H	H	4
L	X	X	NONE-OUT is set to a high impedance state.

L = Low State (0.8V Max.)
H = High State (2.4V Min.)
X = Don't Care

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Absolute Maximum Ratings

Voltage between V+ and V- Terminals	35V
Differential Input Voltage	6V
Voltage at Either Input Terminal	V+ to V-
Voltage on Digital Inputs	GND +7.5V to GND -0.5V
Peak Output Current ($\leq 10\%$ Duty Cycle)	40mA
Junction Temperature (T_J)	+175°C
Storage Temperature Range	-65°C to +150°C
ESD Rating	<2000V
Lead Temperature (Soldering 10s)	+300°C

Thermal Information

Thermal Resistance	θ_{JA}	θ_{JC}
CerDIP Package	82°C/W	27°C/W
Package Power Dissipation Limit at +75°C for $T_J \leq +175^\circ\text{C}$		
CerDIP Package	1.22W	
Package Power Dissipation Derating Factor Above +75°C		
CerDIP Package	12.2mW/°C	

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

Operating Conditions

Operating Temperature Range	-55°C to +125°C	$V_{INCM} \leq 1/2(V+ - V-)$
Operating Supply Voltage	$\pm 12\text{V}$ to $\pm 15\text{V}$	$R_L \geq 1\text{k}\Omega$

TABLE 1. DC ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Tested at: $V_{SUPPLY} = \pm 15\text{V}$, $R_{SOURCE} = 50\Omega$, $R_{LOAD} = 1\text{k}\Omega$, $C_{LOAD} \leq 10\text{pF}$, $V_{OUT} = 0\text{V}$, $V_{IL} = 0.8\text{V}$, $V_{IH} = 2.4\text{V}$,
Unless Otherwise Specified.

PARAMETERS	SYMBOL	CONDITIONS	GROUP A SUBGROUP	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Input Offset Voltage	V_{IO}	$V_{CM} = 0\text{V}$	1	+25°C	-7	7	mV
			2, 3	+125°C, -55°C	-20	20	mV
Channel to Channel Offset Voltage Mismatch	V_{IODEV}	$V_{CM} = 0\text{V}$	1	+25°C	-	5	mV
			2, 3	+125°C, -55°C	-	12	mV
Input Bias Current	+ I_B	$V_{CM} = 0\text{V}$, $+R_S = 250\Omega$ $-R_S = 50\Omega$	1	+25°C	-15	15	μA
			2, 3	+125°C, -55°C	-25	25	μA
	- I_B	$V_{CM} = 0\text{V}$, $+R_S = 50\Omega$ $-R_S = 250\Omega$	1	+25°C	-15	15	μA
			2, 3	+125°C, -55°C	-25	25	μA
Input Offset Current	I_{IO}	$V_{CM} = 0\text{V}$, $+R_S = 250\Omega$ $-R_S = 250\Omega$	1	+25°C	-4	4	μA
			2, 3	+125°C, -55°C	-8	8	μA
Large Signal Voltage Gain	+ A_{VOL}	$V_{OUT} = 0\text{V}$ and +5V	4	+25°C	71	-	dB
			5, 6	+125°C, -55°C	65	-	dB
	- A_{VOL}	$V_{OUT} = 0\text{V}$ and -5V	4	+25°C	71	-	dB
			5, 6	+125°C, -55°C	65	-	dB
Common Mode Rejection Ratio	+CMRR	$\Delta V_{CM} = +5\text{V}$, $V_{OUT} = -5\text{V}$, $V_+ = 10\text{V}$, $V_- = -20\text{V}$	1	+25°C	68	-	dB
			2, 3	+125°C, -55°C	68	-	dB
	-CMRR	$\Delta V_{CM} = -5\text{V}$, $V_{OUT} = +5\text{V}$, $V_+ = 20\text{V}$, $V_- = -10\text{V}$	1	+25°C	68	-	dB
			2, 3	+125°C, -55°C	68	-	dB
Output Voltage Swing	+ V_{OUT}		1	+25°C	10	-	V
			2, 3	+125°C, -55°C	10	-	V
	- V_{OUT}		1	+25°C	-	-10	V
			2, 3	+125°C, -55°C	-	-10	V
Output Current	+ I_{OUT}	$V_{OUT} = -10\text{V}$ $R_{LOAD} = \text{OPEN}$	1	+25°C	25	-	mA
			2, 3	+125°C, -55°C	25	-	mA
	- I_{OUT}	$V_{OUT} = 10\text{V}$ $R_{LOAD} = \text{OPEN}$	1	+25°C	-	-25	mA
			2, 3	+125°C, -55°C	-	-25	mA
Output Current (Device Disabled)	+DISAB	$V_{OUT} = 5\text{V}$, $V_{EN} = 0.8\text{V}$ $R_{LOAD} = \text{OPEN}$	1	+25°C	-	860	μA
			2, 3	+125°C, -55°C	-	860	μA
	-DISAB	$V_{OUT} = -5\text{V}$, $V_{EN} = 0.8\text{V}$ $R_{LOAD} = \text{OPEN}$	1	+25°C	-	860	μA
			2, 3	+125°C, -55°C	-	860	μA

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TABLE 1. DC ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Tested at: $V_{SUPPLY} = \pm 15V$, $R_{SOURCE} = 50\Omega$, $R_{LOAD} = 1k\Omega$, $C_{LOAD} \leq 10pF$, $V_{OUT} = 0V$, $V_{IL} = 0.8V$, $V_{IH} = 2.4V$, Unless Otherwise Specified. (Continued)

PARAMETERS	SYMBOL	CONDITIONS	GROUP A SUBGROUP	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Quiescent Power Supply Current	+I _{CC}	V _{OUT} = 0V I _{OUT} = 0mA	1	+25°C	-	25	mA
			2, 3	+125°C, -55°C	-	25	mA
	-I _{CC}	V _{OUT} = 0V I _{OUT} = 0mA	1	+25°C	-25	-	mA
			2, 3	+125°C, -55°C	-25	-	mA
Supply Current (Device Disabled)	+I _{CCDIS}	V _{OUT} = 0V V _{EN} = 0.8V	1	+25°C	-	10	mA
			2, 3	+125°C, -55°C	-	10	mA
	-I _{CCDIS}	V _{OUT} = 0V V _{EN} = 0.8V	1	+25°C	-10	-	mA
			2, 3	+125°C, -55°C	-10	-	mA
Power Supply Rejection Ratio	+PSRR	$\Delta V_{SUPPLY} = 5V$, V ₊ = 15V, V ₋ = -15V V ₊ = 20V, V ₋ = -15V	1	+25°C	65	-	dB
			2, 3	+125°C, -55°C	65	-	dB
	-PSRR	$\Delta V_{SUPPLY} = 5V$, V ₊ = 15V, V ₋ = -15V V ₊ = 15V, V ₋ = -20V	1	+25°C	65	-	dB
			2, 3	+125°C, -55°C	65	-	dB
Digital Input Voltages (D0, D1, EN)	V _{IL}		1	+25°C	-	0.8	V
			2, 3	+125°C, -55°C	-	0.8	V
	V _{IH}		1	+25°C	2.4	-	V
			2, 3	+125°C, -55°C	2.4	-	V
Input Current (D0, D1)	DX _{IL}	V _{IL} = 0V	1	+25°C	-	1	mA
			2, 3	+125°C, -55°C	-	1	mA
	DX _{IH}	V _{IH} = 5V	1	+25°C	-	1.2	μA
			2, 3	+125°C, -55°C	-	1.2	μA
Input Current (EN)	EN _{IL}	V _{IL} = 0V	1	+25°C	-	50	μA
			2, 3	+125°C, -55°C	-	50	μA
	EN _{IH}	V _{IH} = 5V	1	+25°C	-	1.2	μA
			2, 3	+125°C, -55°C	-	1.2	μA

TABLE 2. AC ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Tested at: $V_{SUPPLY} = \pm 15V$, $R_{SOURCE} = 50\Omega$, $R_{LOAD} = 1k\Omega$, $C_{LOAD} \leq 10pF$, $A_{VCL} = +1V/V$, $V_{IL} = 0.8V$, $V_{IH} = 2.4V$, Unless Otherwise Specified.

PARAMETERS	SYMBOL	CONDITIONS	GROUP A SUBGROUP	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Slew Rate	+SR	V _{OUT} = -5V to +5V	7	+25°C	120	-	V/μs
			8	+125°C, -55°C	120	-	V/μs
	-SR	V _{OUT} = +5V to -5V	7	+25°C	120	-	V/μs
			8	+125°C, -55°C	120	-	V/μs
Channel Select Time	CHSE	Note 1 V _{EN} = 2.4V	9, 10	+25°C, +125°C	-	100	ns
			11	-55°C	-	125	ns
Output Enable Time	CHEN	Note 2	9	+25°C	-	100	ns
			10, 11	+125°C, -55°C	-	100	ns

NOTES:

1. Measured for all channel combinations. Channel Select time is the delay in switching from channel X to channel Y. Channel Y input set to +5V, all other channels set to 0V. Select time is measured from the 50% point of the critical digital select input to the 50% point on the output.
2. Channel 1 selected with the input at 5V. All other channels set to 0V. Enable input switched from 0.8V to 2.4V. Enable time is measured from the 50% point of the EN input to the 50% point on the output.

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TABLE 3. ELECTRICAL PERFORMANCE CHARACTERISTICS

Device Characterized at: $V_{SUPPLY} = \pm 15V$, $R_{SOURCE} = 50\Omega$, $R_{LOAD} = 1k\Omega$, $C_L \leq 10pF$, $A_{VCL} = 1V/V$, $V_{IL} = 0.8V$, $V_{IH} = 2.4V$, Unless Otherwise Specified.

PARAMETERS	SYMBOL	CONDITIONS	NOTES	TEMPERATURE	LIMITS		UNITS
					MIN	MAX	
Rise Time	T_R	$V_{OUT} = 0V$ to $+200mV$	1, 4	+25°C	-	11	ns
			1, 4	-55°C, +125°C	-	12	ns
Fall Time	T_F	$V_{OUT} = 0V$ to $-200mV$	1, 4	+25°C	-	11	ns
			1, 4	-55°C, +125°C	-	12	ns
Overshoot	+OS	$V_{OUT} = 0V$ to $+200mV$	1	+25°C	-	15	%
			1	-55°C, +125°C	-	30	%
	-OS	$V_{OUT} = 0V$ to $-200mV$	1	+25°C	-	15	%
			1	-55°C, +125°C	-	30	%
Full Power Bandwidth	FPBW	$V_{PEAK} = 5V$	1, 2	+25°C	3.8	-	MHz
			1, 2	-55°C, +125°C	3.8	-	MHz
Minimum Closed Loop Stable Gain	CLSG		1	+25°C	1	-	V/V
			1	-55°C, +125°C	1	-	V/V
Quiescent Power Consumption	PC	$V_{OUT} = 0V$, $I_{OUT} = 0mA$	1, 3	+25°C	-	750	mW
			1, 3	-55°C, +125°C	-	750	mW

NOTES:

1. Parameters listed in Table 3 are controlled via design or process parameters and are not directly tested at final production. These parameters are lab characterized upon initial design release, or upon design changes. These parameters are guaranteed by characterization based upon data from multiple production runs which reflect lot to lot and within lot variation.
2. Full Power Bandwidth guarantee based on Slew Rate measurement using $FPBW = \text{Slew Rate}/(2\pi V_{PEAK})$.
3. Power Consumption based upon Quiescent Supply Current test maximum. (No load on outputs.)
4. Measured between 10% and 90% points.

TABLE 4. ELECTRICAL TEST REQUIREMENTS

MIL-STD-883 TEST REQUIREMENTS	SUBGROUPS (SEE TABLES 1 AND 2)
Interim Electrical Parameters (Pre Burn-In)	1
Final Electrical Test Parameters	1 (Note 1), 2, 3, 4, 5, 6, 7, 8, 9, 10, 11
Group A Test Requirements	1, 2, 3, 4, 5, 6, 7, 8, 9, 10, 11
Groups C and D Endpoints	1

NOTE:

1. PDA applies to Subgroup 1 only.

Die Characteristics

DIE DIMENSIONS:

74mils x 103mils x 19mils ± 1mil
 1880µm x 2620µm x 483µm ± 25.4µm

METALLIZATION:

Type: Al, 1% Cu
 Thickness: 16kÅ ± 2kÅ

SUBSTRATE POTENTIAL (Powered Up): V-

GLASSIVATION:

Type: Nitride over SiO_x
 SiO_x Thickness: 12kÅ ± 2kÅ
 Nitride Thickness: 3.5kÅ ± 1.5kÅ

TRANSISTOR COUNT: 129

PROCESS: Bipolar Dielectric Isolation

Metallization Mask Layout

